ISSUE CLASSIFICATION | Class | Subclass

PATENT NUMBER

U.S. UTILITY Patent Application

O.I.P.E.	PATENT DATE
SCANNED IK2 Q.A. TM	

APPLICATION NO.	CONT/PRIOR	CLASS	SUBCLASS	ART UNIT	EXAMINER
09/845179	F	701	35	3661	TRAN

APPLICANTS: Mitsuhiro Nada

TITLE: Abnormality diagnostic system and abnormality diagnostic data storing method

PTO-2040 12/99

ISSUING CLASSIFICATION

ORIGINAL		CROSS REFERENCE(S)	
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLANK)

INTERNATIONAL CLASSIFICATION

Continued

TERMINAL DISCLAIMER	DRAWINGS		
	Sheets Drwg.	Figs. Drwg.	Print Fig.

☐ The term of this patent subsequent to ____ (date) has been disclaimed.

☐ The term of this patent shall not extend beyond the expiration date of U.S. Patent No. ____

☐ The terminal ____ months of this patent have been disclaimed.

(Assistant Examiner) (Date)

Primary Examiner (Date)

(Legal Instrument Examiner) (Date)

NOTICE OF ALLOWANCE MAILED

ISSUE FEE

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